# Search Notes



### Application/Control No.

10566149

Applicant(s)/Patent Under Reexamination

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Examiner

Examme

Art Unit

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1626

### **SEARCHED**

Class	Subclass	Date	Examiner

### **SEARCH NOTES**

Search Notes	Date	Examiner
restriction requirement	2-4-2008	sl
STN: registry & caplus	5-8-2008	sl
PALM all inventors	5-8-2008	sl

## INTERFERENCE SEARCH

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